

Application No.	Applicant(s)	
10/062,873	KIM, JUNG-HYUN	
Examiner	Art Unit	
Alan S Chen	2182	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT; USPGPUB; EPO; TPO; BERWENT; IBM-TDB	8 (6 (04	Asc		
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